

### Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TO-247-4L, 1200 V, 30 mohm

Rev. B, January 2025

#### Description

The UF4SC120030K4S is a 1200V,  $30m\Omega$  G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

#### Features

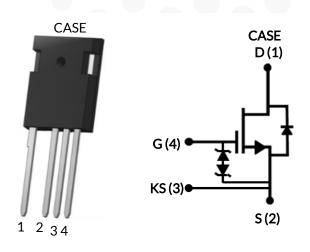
- On-resistance  $R_{DS(on)}$ : 30m $\Omega$  (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q<sub>rr</sub> = 277nC
- Low body diode V<sub>FSD</sub>: 1.22V
- Low gate charge: Q<sub>G</sub> = 37.8nC
- Threshold voltage V<sub>G(th)</sub>: 4.8V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3
- TO-247-4L package for faster switching, clean gate waveforms

#### **Typical applications**

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating

### DATASHEET

# UF4SC120030K4S



Part Number	Package	Marking		
UF4SC120030K4S	TO-247-4L	UF4SC120030K4S		







### **Maximum Ratings**

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V <sub>DS</sub>		1200	V
Gate-source voltage	V	DC	-20 to +20	V
	V <sub>GS</sub>	AC (f > 1Hz)	-25 to +25	V
Continuous drain current <sup>1</sup>	1	T <sub>C</sub> ≤ 40°C	53	А
Continuous drain current	ID	T <sub>C</sub> =100°C	41	А
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	164	А
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =3.6A	97	mJ
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \le 800V$	200	V/ns
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	341	W
Maximum junction temperature	T <sub>J,max</sub>		175	°C
Operating and storage temperature	T <sub>J</sub> , T <sub>STG</sub>		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

1. Limited by bondwires

2. Pulse width  $t_p$  limited by  $T_{J,max}$ 

3. Starting  $T_J = 25^{\circ}C$ 

**Thermal Characteristics** 

Deremeter	Symbol	Test Conditions	Value			Linite
Parameter			Min	Тур	Max	- Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.34	0.44	°C/W



Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

### **Typical Performance - Static**

Parameter	Symbol	Test Conditions		11.20.		
			Min	Тур	Max	- Units
Drain-source breakdown voltage	BV <sub>DS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =1mA	1200			V
Total drain leakage current		V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		1	50	- μΑ
	I <sub>DSS</sub>	V <sub>DS</sub> =1200V, V <sub>GS</sub> =0V, T <sub>J</sub> =175°C		15		
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		6	20	μΑ
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =20A, T <sub>J</sub> =25°C		30	39	
		V <sub>GS</sub> =12V, I <sub>D</sub> =20A, T <sub>J</sub> =125°C		56		mΩ
		V <sub>GS</sub> =12V, I <sub>D</sub> =20A, T <sub>J</sub> =175°C		77		
Gate threshold voltage	$V_{G(th)}$	$V_{DS}$ =5V, $I_{D}$ =10mA	4	4.8	6	V
Gate resistance	R <sub>G</sub>	f=1MHz, open drain		4.5		Ω

#### Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		- Units		
			Min	Тур	Max	Onits
Diode continuous forward current <sup>1</sup>	ا <sub>s</sub>	T <sub>C</sub> ≤ 40°C			53	А
Diode pulse current <sup>2</sup>	I <sub>S,pulse</sub>	T <sub>C</sub> = 25°C			164	А
Forward voltage	V <sub>FSD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =15A, T <sub>J</sub> =25°C		1.22	1.35	V
		V <sub>GS</sub> =0V, I <sub>S</sub> =15A, T <sub>J</sub> =175°C		1.68		
Reverse recovery charge	Q <sub>rr</sub>	$V_{R}$ =800V, I <sub>S</sub> =30A, $V_{GS}$ =0V, R <sub>G</sub> =18 $\Omega$		277		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1840A/μs, T_=25°C		14		ns
Reverse recovery charge	Q <sub>rr</sub>	$V_{R}$ =800V, I <sub>S</sub> =30A, $V_{GS}$ =0V, R <sub>G</sub> =18 $\Omega$		298		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=1840A/μs, Tյ=150°C		12.8		ns





#### **Typical Performance - Dynamic**

Parameter	Symbol	Test Conditions		Linite		
		Test Conditions	Min	Тур	Max	Units
Input capacitance	C <sub>iss</sub>	- V <sub>DS</sub> =800V, V <sub>GS</sub> =0V -		1450		
Output capacitance	C <sub>oss</sub>	- f=100kHz		65		pF
Reverse transfer capacitance	C <sub>rss</sub>			2		
Effective output capacitance, energy related	C <sub>oss(er)</sub>	$V_{DS}=0V$ to 800V, $V_{GS}=0V$		82		pF
Effective output capacitance, time related	C <sub>oss(tr)</sub>	$V_{DS}=0V$ to 800V, $V_{GS}=0V$		150		pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V		26		μJ
Total gate charge	Q <sub>G</sub>	– V <sub>DS</sub> =800V, I <sub>D</sub> =30A, –		37.8		
Gate-drain charge	$Q_{GD}$	$V_{DS} = 000 V, I_D = 30 A,$ - $V_{GS} = 0V \text{ to } 15V$ -		8		nC
Gate-source charge	$Q_{GS}$	V <sub>GS</sub> - 0V to 15V		11.8		
Turn-on delay time	t <sub>d(on)</sub>			12		
Rise time	t <sub>r</sub>	Note 4 and 5,		19		
Turn-off delay time	t <sub>d(off)</sub>	V <sub>DS</sub> =800V, I <sub>D</sub> =30A, Gate		77		ns
Fall time	t <sub>f</sub>	$- Driver = 0V to + 15V, - R_{G ON} = 1\Omega, R_{G OFF} = 18\Omega,$		11		
Turn-on energy including R <sub>s</sub> energy	E <sub>ON</sub>	inductive Load,		423		
Turn-off energy including $R_s$ energy	E <sub>OFF</sub>	FWD: same device with $V_{GS}$ = 0V and $R_G$ =18 $\Omega$ ,		73		
Total switching energy	E <sub>TOTAL</sub>	= 0V and $R_G = 18\Omega$ , Snubber: $R_s = 10\Omega$ , $C_s = 47pF$		496		μJ
Snubber $R_s$ energy during turn-on	E <sub>RS_ON</sub>	T <sub>J</sub> =25°C		1.7		
Snubber $R_s$ energy during turn-off	$E_{RS_OFF}$			1.5		
Turn-on delay time	t <sub>d(on)</sub>			13		
Rise time	t <sub>r</sub>	Note 4 and 5,		20		
Turn-off delay time	t <sub>d(off)</sub>	V <sub>DS</sub> =800V, I <sub>D</sub> =30A, Gate		85		ns
Fall time	t <sub>f</sub>	Driver =0V to +15V, $R_{G_ON}=1\Omega$ , $R_{G_OFF}=18\Omega$ , inductive Load, FWD: same device with V <sub>GS</sub> = 0V and $R_G = 18\Omega$ , Snubber: $R_s=10\Omega$ , $C_s=47pF$ $T_J=150°C$		12		
Turn-on energy including R <sub>S</sub> energy	E <sub>ON</sub>			500		
Turn-off energy including R <sub>s</sub> energy	E <sub>OFF</sub>			97		
Total switching energy	E <sub>TOTAL</sub>			597		μJ
Snubber $R_s$ energy during turn-on	E <sub>rs_on</sub>			1.6		
Snubber $R_s$ energy during turn-off	$E_{RS_OFF}$			1.4		

4. Measured with the switching test circuit in Figure 26.

5. In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.



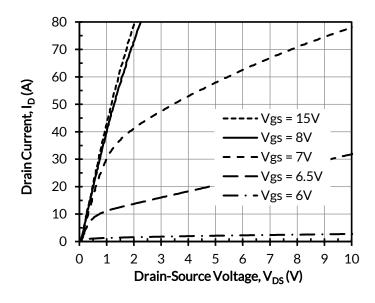


Figure 1. Typical output characteristics at T<sub>J</sub> = - 55°C, tp < 250 $\mu$ s

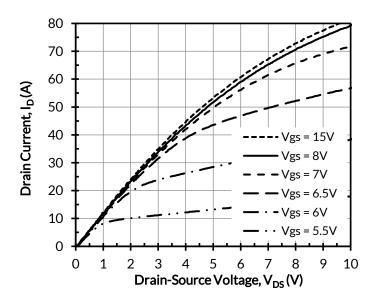
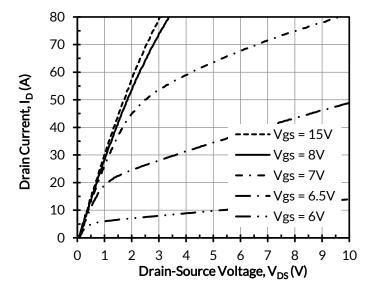


Figure 3. Typical output characteristics at T<sub>J</sub> =  $175^{\circ}$ C, tp <  $250\mu$ s



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Figure 2. Typical output characteristics at  $T_J = 25^{\circ}$ C, tp < 250 $\mu$ s

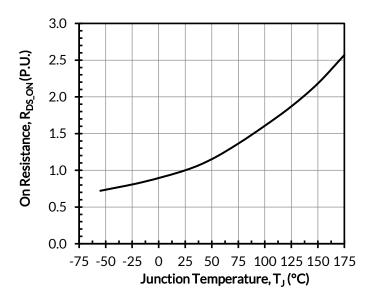


Figure 4. Normalized on-resistance vs. temperature at  $V_{GS}$  = 12V at  $I_{D}$  = 30A

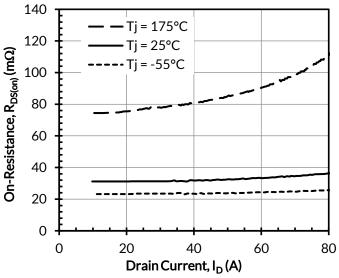
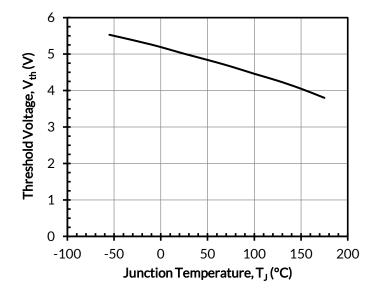




Figure 6. Typical transfer characteristics at  $V_{DS}$  = 5V

Gate-Source Voltage, V<sub>GS</sub>(V)



 $V_{\text{DS}}$  = 5V and  $I_{\text{D}}$  = 10mA

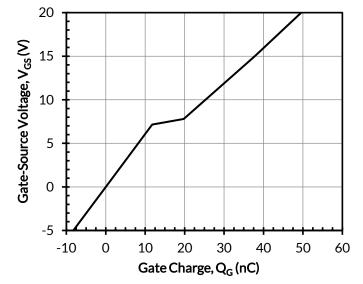


Figure 7. Threshold voltage vs. junction temperature at Figure 8. Typical gate charge at  $V_{DS}$  = 5V and  $I_D$  = 30A

Drain Current, I<sub>D</sub> (A) 20 10 0 5 6 7 8 9 0 1 2 3 4

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Tj = -55°C

Tj = 25°C

Tj = 175°C

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30

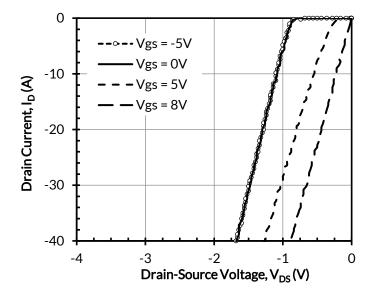
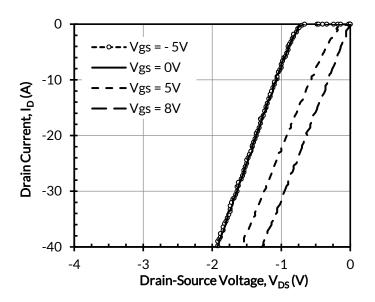


Figure 9. 3rd quadrant characteristics at  $T_J = -55^{\circ}C$ 



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Figure 10. 3rd quadrant characteristics at T<sub>J</sub> = 25°C

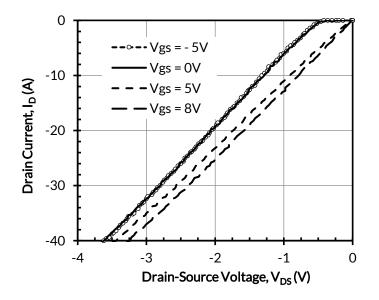


Figure 11. 3rd quadrant characteristics at T<sub>J</sub> = 175°C

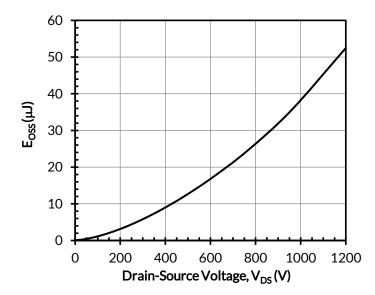


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS}$  = 0V

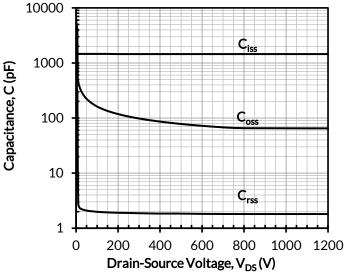
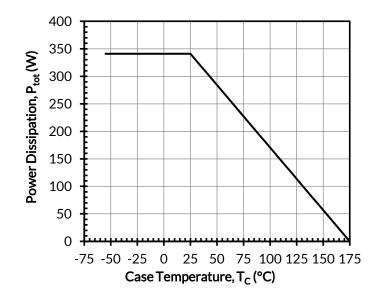


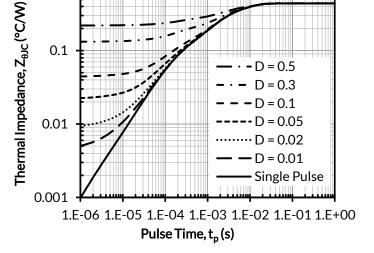
Figure 13. Typical capacitances at f = 100kHz and V<sub>GS</sub> = 0V



0

Case Temperature, T<sub>C</sub> (°C)





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30

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10

0

1

-75 -50 -25

DC Drain Current, I<sub>D</sub> (A)

Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance

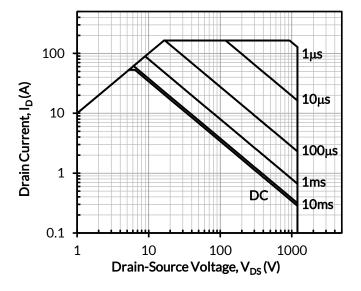
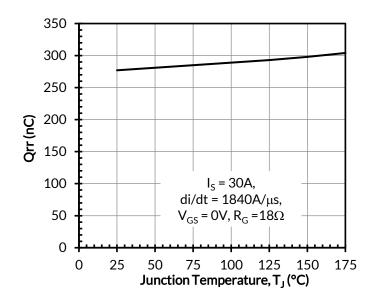


Figure 17. Safe operation area at  $T_C$  = 25°C, D = 0, Parameter  $t_p$ 



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Figure 18. Reverse recovery charge Qrr vs. junction temperature at  $V_{DS}$  = 800V

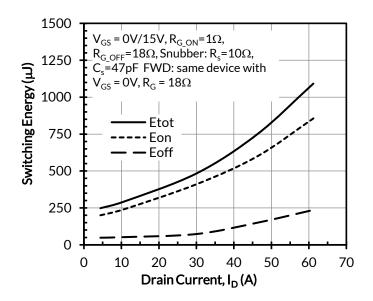


Figure 19. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 800V and  $T_J$  = 25°C

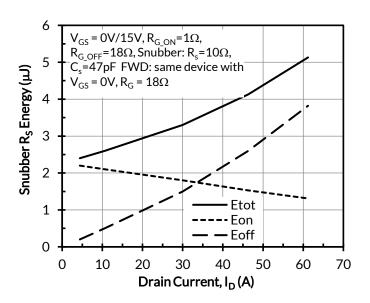


Figure 20. RC snubber energy losses vs. drain current at  $V_{DS}$  = 800V,  $I_D$  = 30A, and  $T_J$  = 25°C

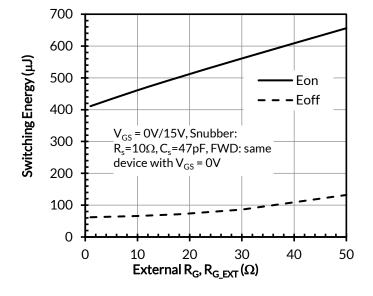
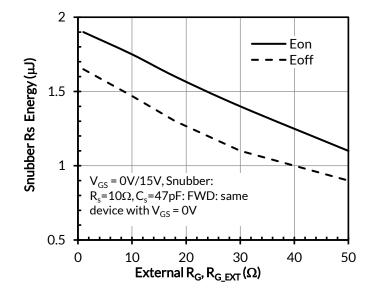


Figure 21. Clamped inductive switching energies vs.  $R_{G,EXT}$  at  $V_{DS}$  = 800V,  $I_D$  =30A, and  $T_J$  = 25°C



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Figure 22. RC snubber energy losses vs.  $R_{G,EXT}$  at  $V_{DS}$  = 800V,  $I_D$  = 30A, and  $T_J$  = 25°C

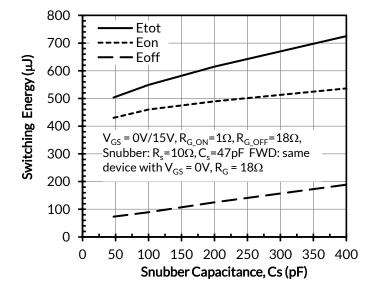


Figure 23. Clamped inductive switching energies vs. snubber capacitance  $C_s$  at  $V_{DS}$  = 800V,  $I_D$  = 30A, and

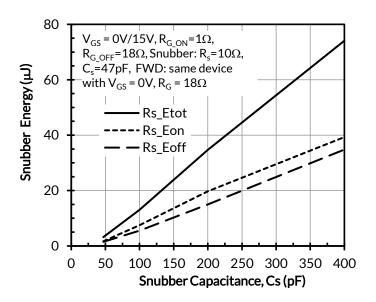


Figure 24. RC snubber energy losses vs. snubber capacitance  $C_s$  at  $V_{DS}$  = 800V,  $I_D$  = 30A, and  $T_J$  = 25°C

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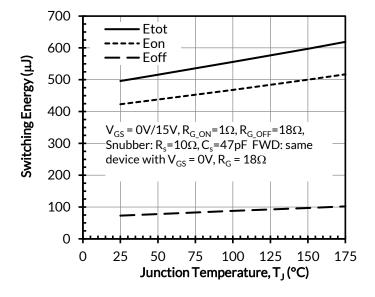


Figure 25. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =800V and  $I_D$  =30A

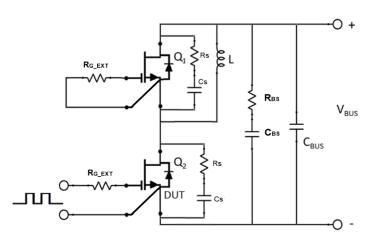


Figure 26. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ( $R_{BS} = 2.5\Omega$ ,  $C_{BS}$ =100nF) is used to reduce the power loop high frequency oscillations.





#### Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode. Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com. A snubber circuit with a small  $R_{(G)}$ , or gate resistor, provides better EMI suppression with higher efficiency compared to using a high  $R_{(G)}$  value. There is no extra gate delay time when using the snubber circuitry, and a small  $R_{(G)}$  will better control both the turn-off  $V_{(DS)}$  peak spike and ringing duration, while a high  $R_{(G)}$ , while greatly reducing  $E_{(OFF)}$  from mid-to-full load range with only a small increase in  $E_{(ON)}$ . Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

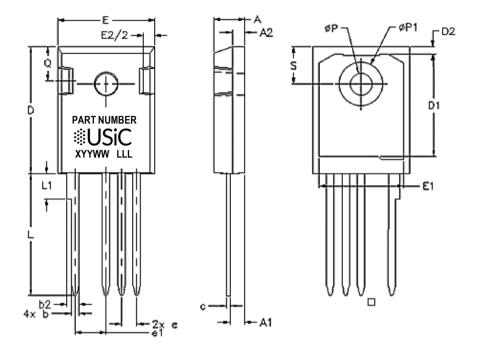
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### TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

### **PACKAGE OUTLINE**



DIM	INC	HES	MILLIN	METERS	
	MIN	MAX	MIN	MAX	
A	0.185	0.209	4.7	5.31	
A1	0.087	0.102	2.21	2.59	
A2	0.059	0.098	1.5	2.49	
b	0.039	0.055	0.99	1.4	
b2	0.065	0.094	1.65	2.39	
С	0.015	0.035	0.38	0.89	
D	0.819	0.845	20.8	21.46	
D1	0.515	-	13.08	-	
D2	0.02	0.053	0.51	1.35	
E	0.61	0.64	15.49	16.26	
e	0.100 BSC		2.54 BSC		
e1	0.19	0.21	4.83	5.33	
E1	0.53	-	13.46	-	
E2	0.14	0.16	3.56 4.06		
L	0.78	0.8	19.81 20.32		
L1	-	0.177	- 4.5		
ФР	0.14	0.144	3.56	3.66	
ΦΡ1	0.278	0.291	7.06 7.39		
Q	0.212	0.244	5.38	6.2	
S	0.243 BSC		6.17 BSC		



### TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PART NUMBER = REFER TO DS\_PN DECODER FOR DETAILS X = ASSEMBLY SITE

YY = YEAR WW = WORK WEEK LLL = LOT ID

### PACKING TYPE

ANTI-STATIC TUBE

**QUANTITY /TUBE : 30 UNITS** 

XYYWW

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